

<b>Notice of References Cited</b>		Application/Control No. 10/789,393	Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
		Examiner EDNY LABBEES	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2002/0025823	02-2002	Hara, Kentaro	455/456
*	B US-7,046,119 B2	05-2006	Ghabra et al.	340/5.72
*	C US-2003/0006879	01-2003	Kang et al.	340/5.61
*	D US-6,778,065	08-2004	Asakura et al.	340/5.61
*	E US-6,556,125	04-2003	Rohrl, Thomas	340/5.62
*	F US-5,293,160	03-1994	Kurozu et al.	340/5.3
*	G US-5,157,389	10-1992	Kurozu et al.	340/5.3
*	H US-6,906,612	06-2005	Ghabra et al.	340/5.61
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
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T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
W	
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